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Geometrical product specifications (GPS) — Acceptance and reverification tests for coordinate measuring systems (CMS) —

Part 10: Laser trackers for measuring point-to-point distances

Spécification géométrique des produits (GPS) — Essais de réception et de vérification périodique des systèmes à mesurer tridimensionnels (SMT) —

Partie 10: Laser de poursuite pour mesurer les distances de point à point

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Page

Forew	ord		iv		
Introd	luction		v		
1	Score		v		
1	scope	-1 - 1	I		
2	Normative references				
3	Terms and definitions				
4	Symbols				
5	Rated operating conditions				
	5.1 Environmental conditions				
	5.2	Operating conditions			
6	Acceptance tests and reverification tests				
	6.1 6.2	General Probing size and form errors	/7		
	0.2	6.2.1 Principle			
		6.2.2 Reference artefact			
		6.2.3 Procedure			
		6.2.4 Derivation of test results			
	6.3	Location errors (two-face tests)			
		6.3.1 Principle			
		6.3.2 REFERENCE AFTERACT, and the first strand and the first strand stra	10		
		634 Derivation of fest results Salten 21	10		
	64	Length errors			
	0.1	6.4.1 General ISO(DIS 10260 10	12		
		6.4.2 http: Principle.itch.ai/cataloo/standards/sist/76h537af-3ca6-4578wach9			
		6.4.3 Reference artefacts	12		
		6.4.4 Procedure	13		
		6.4.5 Derivation of test results	16		
7	Compliance with specification				
	7.1 Acceptance tests				
	7.2	Reverification tests	17		
8	Applic	cations	17		
	8.1	Acceptance test	17		
	8.2	Reverification test			
	8.3	Interim check	18		
9	Indica	tion in product documentation and data sheets			
Annex	A (info	ormative) Forms			
Annex	B (nor	mative) Calibrated test lengths	24		
Annex	c C (nor	mative) Thermal compensation of workpieces			
Annex	D (info	ormative) Specification of MPEs			
Annex E (informative) Interim testing					
Annex	F (nor	mative) Testing of a stylus and retroreflector combination (SRC)			
Annex	G (nor	mative) Testing of an optical distance sensor and retroreflector combination			
	(ODR)	,	40		
Annex	H (info	ormative) Relation to the GPS matrix model	42		
Biblio	graphy	·			

Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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This second edition cancels and replaces 7the list iedition (ISO) 10360-10:2016), which has been technically revised.

The main changes compared to the previous edition are as follows.

Introduction

This document is a geometrical product specification (GPS) standard and is to be regarded as a general GPS standard (see ISO 14638). It influences link F of the chains of standards on size, distance, form, orientation, location, and run-out.

The ISO/GPS matrix model given in ISO 14638 gives an overview of the ISO/GPS system of which this document is a part. The fundamental rules of ISO/GPS given in ISO 8015 apply to this document and the default decision rules given in ISO 14253-1 apply to specifications made in accordance with this document, unless otherwise indicated.

More detailed information on the relation of this document to other standards and the GPS matrix model can be found in <u>Annex H</u>.

The objective of this document is to provide a well-defined testing procedure for:

- a) laser tracker manufacturers to specify performance by maximum permissible errors (MPEs); and
- b) to allow testing of these specifications using calibrated and traceable test lengths, test spheres, and flats.

The benefits of these tests are that the measured result has a direct traceability to the unit of length, the metre, and that it gives information on how the laser tracker will perform on similar length measurements.

This document is distinct from ISO 10360-2, which is for coordinate measuring machines (CMMs) equipped with contact probing systems, in that the orientation of the test lengths reflect the different instrument geometry and error sources within the instrument.

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Geometrical product specifications (GPS) — Acceptance and reverification tests for coordinate measuring systems (CMS) —

Part 10: Laser trackers for measuring point-to-point distances

1 Scope

This document specifies the acceptance tests for verifying the performance of a laser tracker by measuring calibrated test lengths, according to the specifications of the manufacturer. It also specifies the reverification tests that enable the user to periodically reverify the performance of the laser tracker. The acceptance and reverification tests given in this document are applicable only to laser trackers utilizing a retro-reflector as a probing system. Laser trackers that use interferometry (IFM), absolute distance meter (ADM) measurement, or both can be verified using this document. This standard can also be used to specify and verify the relevant performance tests of other spherical coordinate measurement systems that use cooperative targets, such as "laser radar" systems.

NOTE Systems, such as laser radar systems, which do not track the target, will not be tested for probing performance. (standards.iteh.ai)

This document does not explicitly apply to measuring systems that do not use a spherical coordinate system (i.e. two orthogonal rotary axes having a common intersection point with a third linear axis in the radial direction) however, the parties may apply this part of 10360 to such systems by mutual agreement. 19731a2b96c0/iso-dis-10360-10

This document specifies:

- performance requirements that can be assigned by the manufacturer or the user of the laser tracker,
- the manner of execution of the acceptance and reverification tests to demonstrate the stated requirements,
- rules for proving conformance, and
- applications for which the acceptance and reverification tests can be used.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 10360-8:2013, Geometrical product specifications (GPS) — Acceptance and reverification tests for coordinate measuring systems (CMS) — Part 8: CMMs with optical distance sensors

ISO 10360-9:2013, Geometrical product specifications (GPS) — Acceptance and reverification tests for coordinate measuring systems (CMS) — Part 9: CMMs with multiple probing systems

ISO 14253-1:2017, Geometrical product specifications (GPS) — Inspection by measurement of workpieces and measuring equipment — Part 1: Decision rules for verifying conformity or nonconformity with specifications

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <u>https://www.iso.org/obp</u>
- IEC Electropedia: available at <u>http://www.electropedia.org/</u>

3.1

laser tracker

coordinate measuring system in which a cooperative target is followed with a laser beam and its location determined in terms of a distance (range) and two angles

Note 1 to entry: The two angles are referred to as azimuth, θ (rotation about a vertical axis – the standing axis of the laser tracker) and elevation, φ (angle above a horizontal plane – perpendicular to the standing axis).

3.2

interferometric measurement mode IFM mode

measurement method that uses a laser displacement interferometer integrated in a *laser tracker* (3.1) to determine distance (range) to a target

Note 1 to entry: Displacement interferometers can only determine differences in distance, and therefore require a reference distance (e.g. home position).

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3.3 absolute distance measurement modestandards.iteh.ai) ADM mode

measurement method that uses time of flight instrumentation integrated in a *laser tracker* (3.1) to determine the distance (range) to a target integrated in the distance (range) to a target integrated and the distance (range) and the distance (r

Note 1 to entry: Time of flight instrumentation may include a variety of modulation methods to calculate the distance to the target.

3.4

retroreflector

passive device designed to reflect light back parallel to the incident direction over a range of incident angles

Note 1 to entry: Typical retroreflectors are the cat's-eye, the cube corner, and spheres of special material.

Note 2 to entry: Retroreflectors are cooperative targets.

Note 3 to entry: For certain systems, e.g. laser radar, the retroreflector might be a cooperative target such as a polished sphere.

3.5

spherically mounted retroreflector

SMR

retroreflector (3.4) that is mounted in a spherical housing

Note 1 to entry: In the case of an open-air cube corner, the vertex is typically adjusted to be coincident with the sphere centre.

Note 2 to entry: The tests in this standard are typically executed with a spherically mounted retroreflector.

Note 3 to entry: See Figure 1.

3.6 stylus and retroreflector combination SRC

probing system that determines the measurement point utilizing a probe stylus to contact the workpiece, a *retroreflector* (3.4) to determine the base location of the probe, and other means to find the stylus orientation unit vector

Note 1 to entry: The datum for the stylus tip offset (L) is the centre of the retroreflector.

Note 2 to entry: See Figure 1.



- F Stylus of lefitation unit vector
- G normal probing direction vector
- L stylus tip offset

Figure 1 — Representation of SMR vs. SRC

3.7

optical distance sensor and retroreflector combination ODR

probing system that determines the measurement point utilizing an optical distance sensor to measure the workpiece, a *retroreflector* (3.4) to determine the base location of the optical distance sensor, and other means to find the orientation of the optical distance sensor

3.8 target nest nest device designed to repeatably locate an SMR

3.9 length measurement error

E_{Avg:L:LT}

EBi:L:LT

error of indication when performing a averaged ($E_{Avg:L:LT}$) or bidirectional ($E_{Bi:L:LT}$) point-to-point distance measurement of a calibrated test length using a laser tracker with a stylus tip offset of L

Note 1 to entry: $E_{Avg:0:LT}$ and $E_{Bi:0:LT}$ (used frequently in this document) correspond to the common case of no stylus tip offset, as the retroreflector optical centre is coincident with the physical centre of the probing system for spherically mounted retroreflectors.

3.10

normal CTE material

material with a coefficient of thermal expansion (CTE) between 8×10^{-6} / 0 C and 13×10^{-6} / 0 C

[SOURCE: ISO 10360-2:2009]

Note 1 to entry: Some documents may express CTE in units 1 / K, which is equivalent to $1 / {}^{0}C$.

3.11

probing form error

PForm.Sph.1x25:SMR:LT

error of indication within which the range of Gaussian radial distances can be determined by a least-squares fit of 25 points measured by a *laser tracker* (<u>3.1</u>)on a spherical material standard of size

Note 1 to entry: Only one least-squares fit is performed, and each point is evaluated for its distance (radius) from this fitted centre.

3.12

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probing size error P_{Size.Sph.1x25:SMR:LT}

ISO/DIS 10360-10

error of indication of the diameter of a spherical material standard of size as determined by a least-squares fit of 25 points measured with a *lasers tracker* (3.1) is 10360-10

3.13

location error two-face error plunge and reverse error

LDia.2x1:P&R:LT

distance, perpendicular to the beam path, between two measurements of a stationary *retroreflector* (3.4), where the second measurement is taken with the *laser tracker* (3.1) azimuth axis at approximately 180 degrees from the first measurement and the laser tracker elevation angle is approximately the same

Note 1 to entry: This combination of axis rotations is known as a two face, or plunge and reverse, test.

Note 2 to entry: The laser tracker base is fixed during this test.

3.14

maximum permissible error of length measurement

EAvg:L:LT, MPE

*E*Bi:L:LT, MPE extreme value of the length measurement error, $E_{\text{Bi:L:LT}}$ or $E_{\text{Avg:L:LT}}$, permitted by specifications

Note 1 to entry: $E_{\text{Bi:0:LT, MPE}}$ and $E_{\text{Avg:0:LT, MPE}}$ are used throughout this document.

3.15

maximum permissible error of probing form

PForm.Sph.1x25:SMR:LT, MPE

extreme value of the probing form error (3.11), P_{Form.Sph.1x25:SMR:LT}, permitted by specifications

3.16

maximum permissible error of probing size

*P*Size.Sph.1x25:SMR:LT, MPE

extreme value of the probing size error (3.12), $P_{Size.Sph.1x25:SMR:LT}$, permitted by specifications

3.17

maximum permissible error of location

LDia.2x1:P&R:LT. MPE

extreme value of the location error, *L*_{Dia.2x1:P&R:LT}, permitted by specifications

3.18

rated operating condition

operating condition that must be fulfilled, according to specification, during measurement in order that a measuring instrument or measuring system perform as designed

Note 1 to entry: Rated operating conditions generally specify intervals of values for a quantity being measured and for any influence quantity. [VIM 4.9].

Note 2 to entry: Within the ISO 10360- series of standards, the term "as designed" in the definition means "as specified by MPEs".

Note 3 to entry: When the rated operating conditions are not met in a test according to the ISO 10360, neither conformance nor non-conformance to specifications can be determined.

[SOURCE: ISO/IEC Guide 99:2007, 4.9 modified.]

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Symbols 4

For the purpose of this document, the symbols of <u>Table 1</u> apply.

ISO/DIS 10360-10

https://stanTable_1_arc Symbols_of specification_quantities

Symbol	Meaning
E _{Avg:L:LT}	Length measurement error (Averaged or Bi-directional lengths) where L is the stylus tip offset
E _{Bi:L:LT}	
P _{Form.Sph.1x25:SMR:LT}	
P _{Form.Sph.1x25:SRC:LT}	Probing form error
P _{Form.Sph.1x25:ODR:LT}	
P _{Size.Sph.1x25:SMR:LT}	
P _{Size.Sph.1x25:SRC:LT}	Probing size error
P _{Size.Sph.1x25:ODR:LT}	
L _{Dia.2x1:P&R:LT}	Location error (from two face tests)
E _{Avg:L:LT,MPE}	Maximum permissible error of length measurement where L is the stylus tip offset
E _{Bi:L:LT,MPE}	
P _{Form.Sph.1x25} :SMR:LT,MPE	Maximum permissible error of probing form
P _{Size.Sph.1x25} :SMR:LT,MPE	Maximum permissible error of probing size
L _{Dia.2x1:P&R:LT,MPE}	Maximum permissible error of location (from two face tests)
	Accessory sensor testing – SRC
Symbol	Meaning
P _{Form.Sph.1x25:SRC:LT}	Probing form error for SRC
P _{Size.Sph.1x25:SRC:LT}	Probing size error for SRC
P _{Dia.15x1:SRC:LT}	Orientation error for SRC
P _{Form.Sph.1x25:SRC:LT,MPE}	Maximum permissible error of probing form for SRC

Symbol	Meaning
P _{Size.Sph.1x25:SRC:LT,MPE}	Maximum permissible error of probing size for SRC
P _{Dia.15x1:SRC:LT,MPE}	Maximum permissible error of orientation for SRC
	Accessory sensor testing – ODR
Symbol	Meaning
P _{Form.Sph.1×25:ODR:LT}	Probing form error for ODR (25 points)
P _{Form.Sph.D95%:ODR:LT}	Probing form error for ODR (95% of the points)
P _{Size.Sph.1×25:ODR:LT}	Probing size error for ODR (25 points)
P _{Size.Sph.All:ODR:LT}	Probing size error for ODR (all points)
E _{Form.Pla.D95%:ODR:LT}	Flat form error of measurement with ODR (95% of the points)
P _{Form.Sph.1×25:ODR:LT,MPE}	Maximum permissible error of probing form for ODR (25 points)
P _{Form.Sph.D95%:ODR:LT,MPE}	Maximum permissible error of probing form for ODR (95% of the points)
P _{Size.Sph.1×25:ODR:LT,MPE}	Maximum permissible error of probing size for ODR (25 points)
P _{Size.Sph.All:ODR:LT,MPE}	Maximum permissible error of probing size for ODR (all points)
<i>E</i> _{Form.Pla.D95%:ODR:LT,MPE}	Maximum permissible error of flat form measurement with ODR (95% of the points)

Table 1 (continued)

Table 2 — Symbols of specification quantities (continued)

	Multiple sensor testing
Symbol	II ell SIANDARD _{Meaning}
P _{Form.Sph.nx25::MPS.LT}	Multiple probing system form erroriteh.ai)
P _{Size.Sph.nx25} ::MPS.LT	Multiple probing system size error
L _{Dia.n×25::MPS.LT}	Multiple probing system
P _{Form.Sph.nx25} ::MPS.LT,MPE	Maximum per missible multiple probing system form erroreb9-
P _{Size.Sph.nx25} ::MPS.LT,MPE	Maximum permissible multiple probing system size error
<i>L</i> _{Dia.<i>n</i>×25::MPS.LT,MPE}	Maximum permissible multiple probing system location error

NOTE 1 For the common case of length testing with an SMR, L will be equal to 0 (e.g. $E_{\text{Bi:0:LT}}$).

NOTE 2 The specific combinations of sensors for the multiple probing system errors depend on the sensors provided with the laser tracker system. The combination could be explicitly captured in the symbol, such as $P_{Size.}$ Sph.2x25:0DS,SMR:MPS.LT where the symbols indicating sensors are listed alphabetically.

NOTE 3 In the multiple sensor testing entries, n (in $n \times 25$) is the number of sensors being involved ($n \ge 2$).

5 Rated operating conditions

5.1 Environmental conditions

Limits for permissible environmental conditions such as temperature conditions, air pressure, humidity, and vibration at the site of usage or testing that influence the measurements shall be specified by

- the manufacturer, in the case of acceptance tests;
- the user, in the case of reverification tests.

In both cases, the user is free to choose the environmental conditions under which the testing will be performed within the specified limits (Form 1 in <u>Annex A</u> is the recommended method for specifying these conditions).

If the user wishes to have testing performed under environmental conditions other than the ambient conditions of the test site (e.g. at an elevated or lowered temperature), agreement between parties regarding who bears the cost of environmental conditioning should be attained.

5.2 Operating conditions

The conditions required by the manufacturer in order to meet the MPE specification shall be specified (as given, e.g. in a specification sheet).

In addition, the laser tracker shall be operated using the procedures given in the manufacturer's operating manual when conducting the tests given in <u>Clause 6</u>. Specific areas in the manufacturer's manual to be adhered to are, for example:

- a) machine start-up/warm-up cycles,
- b) machine compensation procedures,
- c) cleaning procedures for retroreflector and nests,
- d) SMR or SRC qualification,
- e) location, type, and number of environmental sensors (i.e. "the weather station"), and
- f) location, type, number of thermal workpiece sensors.

6 Acceptance tests and reverification tests **PREVIEW**

6.1 General

In the following

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- acceptance tests are executed according to the manufacturer's specifications and procedures that are in compliance with this document, and
- reverification tests are executed according to the user's specifications and the manufacturer's procedures.

If specifications permit, the laser tracker may be tested in an orientation other than the normal upright, vertical orientation. In every case, the azimuth and elevation angles will be oriented with respect to the laser tracker. The position and orientation of the test lengths with respect to the laser tracker shall be clearly defined before the tests begin. In general, the test lengths will not rotate with the laser tracker. However, the locations for probing and two-face tests will maintain a fixed relationship with respect to the laser tracker's standing axis (i.e. they will rotate with the laser tracker). For example, if the laser tracker is mounted with its standing axis horizontal, the 'above' and 'below' directions described in Table 3 and Table 4 will be parallel to the standing axis.

Where least squares (Gaussian) fitting is used in the derivation of test results, this shall be an unconstrained fit to the data, unless constraints to the fitting are explicitly stated.

6.2 Probing size and form errors

6.2.1 Principle

The principle of this test procedure is to measure the size and form of a test sphere using 25 points probed with the SMR, SRC, or ODR. This Clause gives the specific testing procedure for using an SMR to collect the points. Refer to normative <u>Annex G</u> or normative <u>Annex H</u> for additional information about testing with the SRC or ODR sensors, respectively. A least-squares sphere fit of the 25 points is examined